

# EE 322 Advanced Analog Electronics, Spring 2013

## Handout 3: Amplifier stability - op-amp frequency response

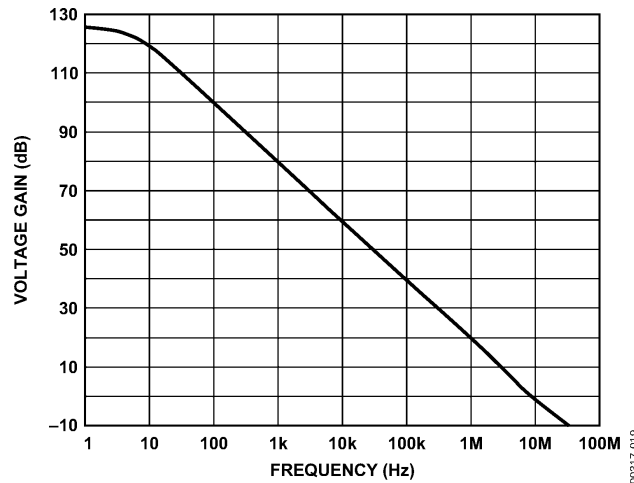


Figure 19. Open-Loop Gain vs. Frequency

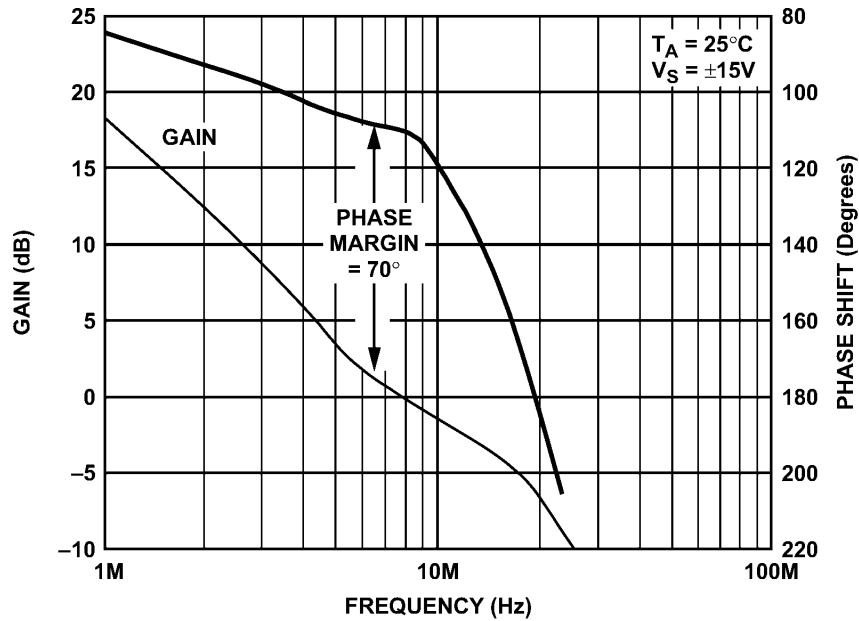


Figure 21. Gain, Phase Shift vs. Frequency

Table 4.

Parameter	Symbol	Conditions	OP27N Typical	Unit
AVERAGE INPUT OFFSET VOLTAGE DRIFT <sup>1</sup>	TCV <sub>OS</sub> or TCV <sub>OSn</sub>	Nullled or unnullled R <sub>P</sub> = 8 k $\Omega$ to 20 k $\Omega$	0.2	$\mu\text{V}/^\circ\text{C}$
AVERAGE INPUT OFFSET CURRENT DRIFT	TCI <sub>OS</sub>		80	pA/ $^\circ\text{C}$
AVERAGE INPUT BIAS CURRENT DRIFT	TCI <sub>B</sub>		100	pA/ $^\circ\text{C}$
INPUT NOISE VOLTAGE DENSITY	e <sub>n</sub>	f <sub>0</sub> = 10 Hz	3.5	nV/ $\sqrt{\text{Hz}}$
	e <sub>n</sub>	f <sub>0</sub> = 30 Hz	3.1	nV/ $\sqrt{\text{Hz}}$
	e <sub>n</sub>	f <sub>0</sub> = 1000 Hz	3.0	nV/ $\sqrt{\text{Hz}}$
INPUT NOISE CURRENT DENSITY	i <sub>n</sub>	f <sub>0</sub> = 10 Hz	1.7	pA/ $\sqrt{\text{Hz}}$
	i <sub>n</sub>	f <sub>0</sub> = 30 Hz	1.0	pA/ $\sqrt{\text{Hz}}$
	i <sub>n</sub>	f <sub>0</sub> = 1000 Hz	0.4	pA/ $\sqrt{\text{Hz}}$
INPUT NOISE VOLTAGE SLEW RATE	e <sub>np-p</sub>	0.1 Hz to 10 Hz	0.08	$\mu\text{V p-p}$
	SR	R <sub>L</sub> $\geq$ 2 k $\Omega$	2.8	V/ $\mu\text{s}$
GAIN BANDWIDTH PRODUCT	GBW		8	MHz

<sup>1</sup> Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power.